

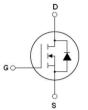
N-Channel Super Junction Power MOSFET

General Description

The series of devices use advanced super junction technology and design to provide excellent R_{DS(ON)} with low gate charge. This super junction MOSFET fits the industry's AC-DC SMPS requirements for PFC, AC/DC power conversion, and industrial power applications.

Features

- New technology for high voltage device
- Low on-resistance and low conduction losses
- Small package
- Ultra Low Gate Charge cause lower driving requirements
- 100% Avalanche Tested
- ROHS compliant





Application

- Power factor correction (PFC)
- Switched mode power supplies(SMPS)
- Uninterruptible Power Supply (UPS)

Vds	650	V
	1200	mΩ
lD	4	А

Schematic diagram

TO-220F

Package Marking And Ordering Information

Device	Device Package	Marking
MJ65R1K2F	TO-220F	MJ65R1K2F

Table 1. Absolute Maximum Ratings (Tc=25℃)

Parameter	Symbol	MJ65R1K2F	Unit
Drain-Source Voltage (Ves=0V)	Vds	650	V
Gate-Source Voltage (V _{DS} =0V)	Vgs	±30	V
Continuous Drain Current at Tc=25°C	ID (DC)	4*	А
Continuous Drain Current at Tc=100°C	ID (DC)	2.5	А
Pulsed drain current (Note 1)	DM (pluse)	12	А
Maximum Power Dissipation (Tc=25°C)	PD	28.5	W
Derate above 25°C	Po	0.23	W/°C
Single pulse avalanche energy (Note 2)	Eas	130	mJ
Avalanche current (Note 1)	lar	2	А
Repetitive Avalanche energy , t_{AR} limited by $T_{jmax} ^{(Note \ 1)}$	Ear	0.2	mJ

Parameter	Symbol	MJ65R1K2F	Unit
Drain Source voltage slope, V⊳s ≤480 V	dv/dt	50	V/ns
Reverse diode dv/dt, VDs ≤480 V,IsD <id< td=""><td>dv/dt</td><td>15</td><td>V/ns</td></id<>	dv/dt	15	V/ns
Operating Junction and Storage Temperature Range	Тյ,Тsтg	-55+150	°C

* limited by maximum junction temperature





Table 2. Thermal Characteristic

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Maximum)	RthJC	4.4	°C/W
Thermal Resistance, Junction-to-Ambient (Maximum)	RthJA	80	°C/W

Table 3. Electrical Characteristics (T_A=25℃ unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
On/off states						
Drain-Source Breakdown Voltage	BVDSS	Vgs=0V Id=250µA	650	-	-	V
Zero Gate Voltage Drain Current (Tc=25°C)	loss	VDS=650V,VGS=0V	-	-	1	μA
Zero Gate Voltage Drain Current (Tc=125℃)	loss	VDS=650V,VGS=0V	-	-	50	μA
Gate-Body Leakage Current	lgss	Vgs=±30V,Vds=0V	-	-	±100	nA
Gate Threshold Voltage	VGS(th)	V _{DS} =V _{GS} ,I _D =250µA	2.5	3	3.5	V
Drain-Source On-State Resistance	Rds(on)	Vgs=10V,Id=2.5A	-	1000	1200	mΩ
Dynamic Characteristics	I	1		1	1	
Forward Transconductance	g FS	V _{DS} =20V,I _D =2.5A	-	4	-	S
Input Capacitance	Cies		-	280	-	PF
Output Capacitance	Coss	V _{DS} =50V,V _{GS} =0V F=1.0MHz	-	26	_	PF
Reverse Transfer Capacitance	Crss	-	-	2.3	-	PF
Total Gate Charge	Qg		-	6.5	10	nC
Gate-Source Charge	Qgs	V _{DS} =480V,I _D =4A V _{GS} =10V	-	1.3	_	nC
Gate-Drain Charge	Qgd	-	-	2.5	-	nC
Intrinsic gate resistance	Rg	f=1 MHz open drain	-	2.5	_	Ω
Switching times		1		1	1	1
Turn-on Delay Time	td(on)		-	6	-	nS
Turn-on Rise Time	tr	Vdd=380V,Id=2.5A	_	3	-	nS
Turn-Off Delay Time	td(off)	R _G =20Ω,V _{GS} =10V	-	48	60	nS
Turn-Off Fall Time	tr	-	-	8	15	nS
Source- Drain Diode Characteristics				1	<u> </u>	1
Source-drain current (Body Diode)	Isd		-	-	4	A
Pulsed Source-drain current (Body Diode)	Іздм	- Tc=25°C	-	-	12	A
Forward On Voltage	Vsd	Tj=25°C,Isd=4A,Vgs=0V	-	1	1.3	V
Reverse Recovery Time	trr		_	150		nS
Reverse Recovery Charge	Qrr	Tj=25°C,I⊧=4A di/dt=100A/μs	-	0.85	-	uC
Peak reverse recovery current	Irrm		_	11		A

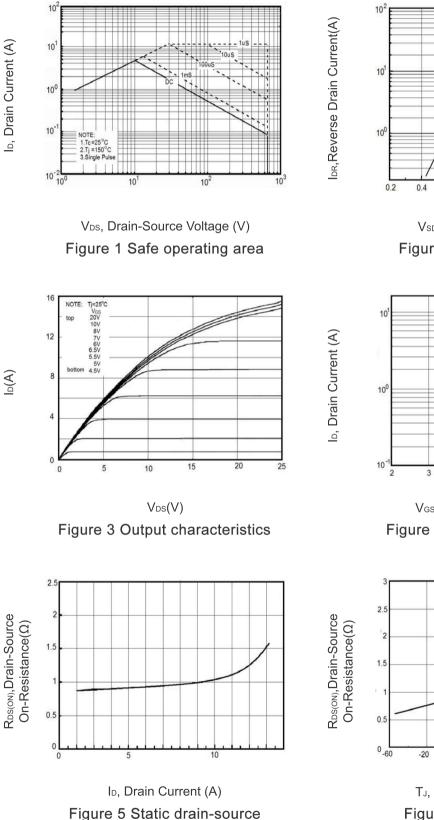




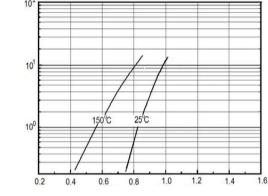
Notes

1.Repetitive Rating: Pulse width limited by maximum junction temperature 2.Tj=25°C,VDD=50V,VG=10V, RG=25 Ω

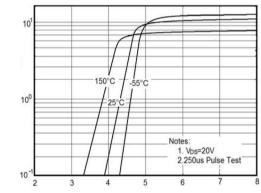
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (curves)



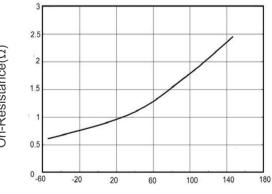
on resistance



Vsd,Source-Drain Voltage(V) Figure 2 Source-Drain Diode Forward Voltage



V_{GS}, Gate-Source Voltage (V) Figure 4 Transfer characteristics



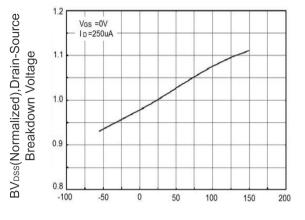
TJ, Junction Temperature (°C) Figure 6 RDS(ON) vs Junction Temperature



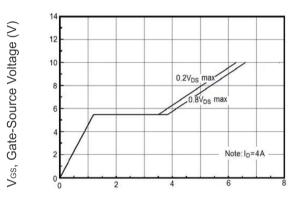


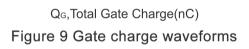
I_D, Drain Current (A)

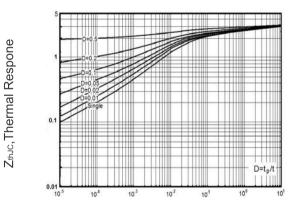
Capacitances(pF)



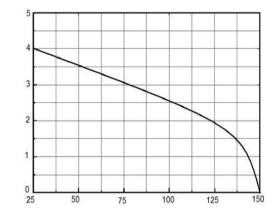
TJ, Junction Temperature (°C) Figure 7 BVDss vs Junction Temperature



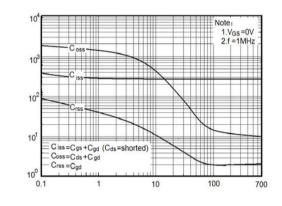




t_₽,Square Wave Pulse(S) Figure 11 Transient Thermal Impedance



Tc, Case Temperature (°C) Figure 8 Maximum I⊵ vs Junction Temperature



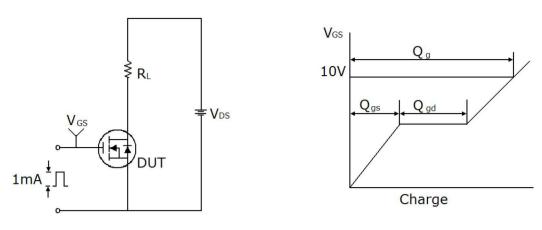
V_{DS}, Drain-Source Voltage (V) Figure 10 Capacitance



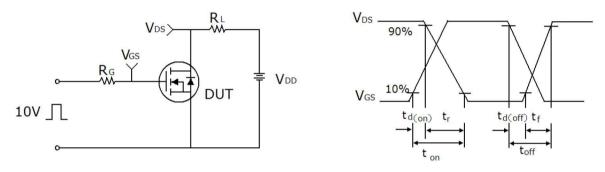




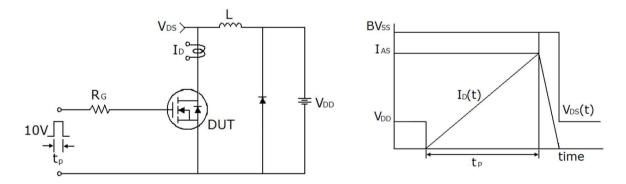
Test circuit



Gate charge test circuit & Waveform



Switch Time Test Circuit



Unclamped Inductive Switching Test Circuit & Waveforms







2.54 ±0.20

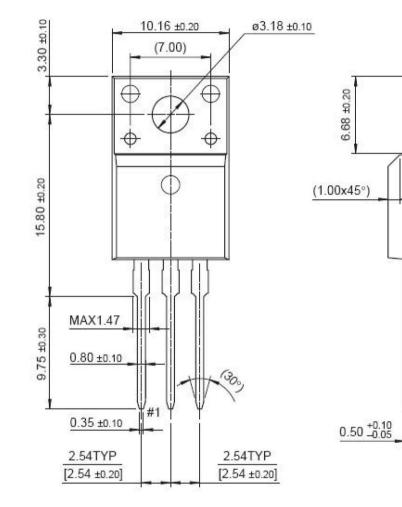
(0.70)

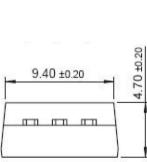
15.87 ±0.20

2.76 ±0.20

D

TO-220F Package Information





Dimensions in Millimeters





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